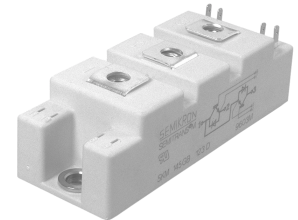


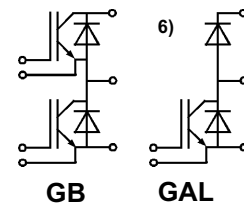
| Absolute Maximum Ratings             |   | Values             | Units            |
|--------------------------------------|---|--------------------|------------------|
| Symbol                               | Conditions <sup>1)</sup>                              |                    |                  |
| V <sub>CES</sub>                     |   | 1700               | V                |
| V <sub>CGR</sub>                     | R <sub>GE</sub> = 20 kΩ                               | 1700               | V                |
| I <sub>C</sub>                       | T <sub>case</sub> = 25/80 °C                          | 110 / 75           | A                |
| I <sub>CM</sub>                      | T <sub>case</sub> = 25/80 °C; t <sub>p</sub> = 1 ms   | 220 / 150          | A                |
| V <sub>GES</sub>                     |   | ± 20               | V                |
| P <sub>tot</sub>                     | per IGBT, T <sub>case</sub> = 25 °C                   | 625                | W                |
| T <sub>j</sub> , (T <sub>stg</sub> ) |   | -40 ... +150 (125) | °C               |
| V <sub>isol</sub>                    | AC, 1 min.  | 4000               | V                |
| humidity                             | DIN 40 040  | Class F            |                  |
| climate                              | DIN IEC 68 T.1  | 40/125/56          |                  |
| Inverse Diode <sup>8)</sup>          |   |                    |                  |
| I <sub>F</sub> = -I <sub>C</sub>     | T <sub>case</sub> = 25/80 °C                          | 80 / 50            | A                |
| I <sub>FM</sub> = -I <sub>CM</sub>   | T <sub>case</sub> = 25/80 °C; t <sub>p</sub> = 1 ms   | 200 / 150          | A                |
| I <sub>FSM</sub>                     | t <sub>p</sub> = 10 ms; sin.; T <sub>j</sub> = 150 °C | 720                | A                |
| I <sup>2</sup> t                     | t <sub>p</sub> = 10 ms; T <sub>j</sub> = 150 °C       | 2600               | A <sup>2</sup> s |

## SEMITRANS® M IGBT Modules

### SKM 100 GB 173 D SKM 100 GAL 173 D <sup>6)</sup>



### SEMITRANS 2



### Features

- N channel, Homogeneous Si
- Very low tail current with low temperature dependence
- High short circuit capability, self limiting to 6 \* I<sub>cnom</sub>
- Latch-up free
- Fast & soft inverse CAL diodes <sup>8)</sup>
- Isolated copper baseplate using DCB Direct Copper Bonding
- Large clearance (10 mm) and creepage distances (20 mm)

### Typical Applications

- AC inverter driveson mains 575 - 750 V<sub>AC</sub>
- DC bus voltage 750 - 1200 V<sub>DC</sub>
- Public transport (auxiliary syst.)
- Switching (not for linear use)

| Characteristics                    |  | min.               | typ.       | max.     | Units |
|------------------------------------|--|--------------------|------------|----------|-------|
| Symbol                             | Conditions <sup>1)</sup>   |                    |            |          |       |
| V <sub>(BR)CES</sub>               | V <sub>GE</sub> = 0, I <sub>C</sub> = 1,4 mA                       | ≥ V <sub>CES</sub> | -          | -        | V     |
| V <sub>GE(th)</sub>                | V <sub>GE</sub> = V <sub>CE</sub> , I <sub>C</sub> = 6 mA          | 4,8                | 5,5        | 6,2      | V     |
| I <sub>CES</sub>                   | V <sub>GE</sub> = 0 } T <sub>j</sub> = 25 °C                       | -                  | 0,1        | 1        | mA    |
|                                    | V <sub>CE</sub> = V <sub>CES</sub> } T <sub>j</sub> = 125 °C       | -                  | -          | 15       | mA    |
| I <sub>GES</sub>                   | V <sub>GE</sub> = 20 V, V <sub>CE</sub> = 0                        | -                  | -          | 400      | nA    |
| V <sub>CESat</sub>                 | I <sub>C</sub> = 75 A } V <sub>GE</sub> = 15 V;                    | -                  | 3,4(4,4)   | 3,9(5)   | V     |
|                                    | I <sub>C</sub> = 100 A } T <sub>j</sub> = 25 (125) °C }            | -                  | 3,8(5,5)   | -        | V     |
| g <sub>fs</sub>                    | V <sub>CE</sub> = 20 V, I <sub>C</sub> = 75 A                      | 27                 | -          | -        | S     |
| C <sub>CHC</sub>                   | per IGBT   | -                  | -          | 200      | pF    |
| C <sub>ies</sub>                   | V <sub>GE</sub> = 0  | -                  | 11         | -        | nF    |
| C <sub>oes</sub>                   | V <sub>CE</sub> = 25 V   | -                  | 1          | -        | nF    |
| C <sub>res</sub>                   | f = 1 MHz  | -                  | 0,28       | -        | nF    |
| L <sub>CE</sub>                    |  | -                  | -          | 30       | nH    |
| t <sub>d(on)</sub>                 | V <sub>CC</sub> = 1200 V   | -                  | 40         | -        | ns    |
| t <sub>r</sub>                     | V <sub>GE</sub> = -15 V / +15 V                                    | -                  | 45         | -        | ns    |
| t <sub>d(off)</sub>                | I <sub>C</sub> = 75 A, ind. load                                   | -                  | 400        | -        | ns    |
| t <sub>f</sub>                     | R <sub>Gon</sub> = R <sub>Goff</sub> = 10 Ω                        | -                  | 56         | -        | ns    |
| E <sub>on</sub>                    | T <sub>j</sub> = 125 °C  | -                  | 35         | -        | mWs   |
| E <sub>off</sub>                   |  | -                  | 21         | -        | mWs   |
| Inverse Diode <sup>8)</sup>        |  |                    |            |          |       |
| V <sub>F</sub> = V <sub>EC</sub>   | I <sub>F</sub> = 75 A } V <sub>GE</sub> = 0 V;                     | -                  | 2,2(2,0)   | 2,7(2,3) | V     |
| V <sub>F</sub> = V <sub>EC</sub>   | I <sub>F</sub> = 100 A } T <sub>j</sub> = 25 (125) °C }            | -                  | 2,45(2,25) | -        | V     |
| V <sub>TO</sub>                    | T <sub>j</sub> = 125 °C  | -                  | 1,3        | 1,5      | V     |
| r <sub>t</sub>                     | T <sub>j</sub> = 125 °C  | -                  | 9          | 13       | mΩ    |
| I <sub>R</sub> RM                  | I <sub>F</sub> = 75 A; T <sub>j</sub> = 25 (125) °C <sup>2)</sup>  | -                  | 38(51)     | -        | A     |
| Q <sub>rr</sub>                    | I <sub>F</sub> = 75 A; T <sub>j</sub> = 25 (125) °C <sup>2)</sup>  | -                  | 8(19)      | -        | μC    |
| FWD of type "GAL" <sup>6) 8)</sup> |  |                    |            |          |       |
| V <sub>F</sub> = V <sub>EC</sub>   | I <sub>F</sub> = 100 A } V <sub>GE</sub> = 0 V;                    | -                  | 2,2(1,9)   | 2,7(2,4) | V     |
| V <sub>TO</sub>                    | T <sub>j</sub> = 125 °C  | -                  | 1,2        | 1,5      | V     |
| r <sub>t</sub>                     | T <sub>j</sub> = 125 °C  | -                  | 7          | 9        | mΩ    |
| t <sub>rr</sub>                    | I <sub>F</sub> = 100 A; T <sub>j</sub> = 25 (125) °C <sup>2)</sup> | -                  | 50(70)     | -        | μs    |
| Q <sub>rr</sub>                    | I <sub>F</sub> = 100 A; T <sub>j</sub> = 25 (125) °C <sup>2)</sup> | -                  | 10(27)     | -        | μC    |
| Thermal characteristics            |  |                    |            |          |       |
| R <sub>thjc</sub>                  | per IGBT   | -                  | -          | 0,2      | °C/W  |
| R <sub>thjc</sub>                  | per diode / FWD "GAL"  | -                  | -          | 0,63/0,4 | °C/W  |
| R <sub>thch</sub>                  | per module   | -                  | -          | 0,05     | °C/W  |

<sup>1)</sup> T<sub>case</sub> = 25 °C, unless otherwise specified

<sup>2)</sup> I<sub>F</sub> = -I<sub>C</sub>, V<sub>R</sub> = 1200 V, -di<sub>F</sub>/dt = 800 A/μs, V<sub>GE</sub> = 0 V

<sup>6)</sup> The free-wheeling diode of the GAL type has the data of the inverse diode of SKM 150 GB 173 D

<sup>8)</sup> CAL = Controlled Axial Lifetime Technology

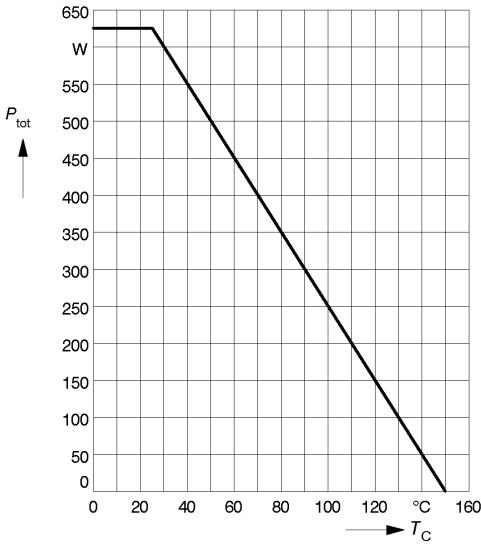


Fig. 1 Rated power dissipation  $P_{tot} = f(T_C)$

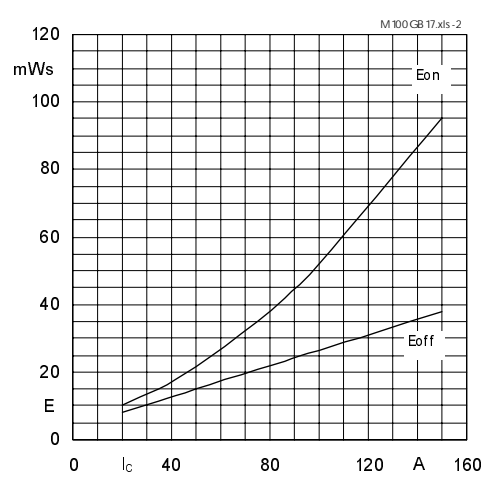


Fig. 2 Turn-on /-off energy  $= f(I_C)$

$T_j = 125\text{ °C}$   
 $V_{CE} = 1200\text{ V}$   
 $V_{GE} = \pm 15\text{ V}$   
 $R_G = 10\text{ }\Omega$

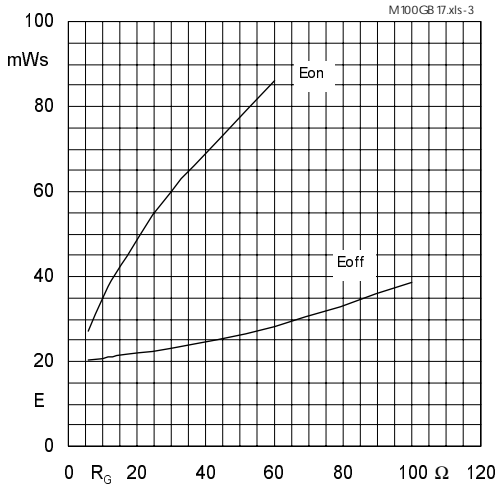


Fig. 3 Turn-on /-off energy  $= f(R_G)$

$T_j = 125\text{ °C}$   
 $V_{CE} = 1200\text{ V}$   
 $V_{GE} = \pm 15\text{ V}$   
 $I_C = 75\text{ A}$

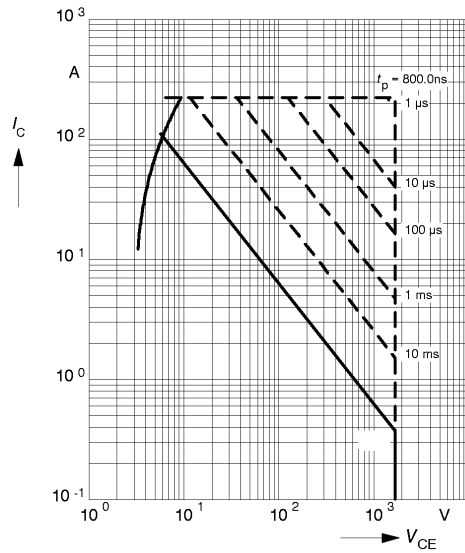


Fig. 4 Maximum safe operating area (SOA)  $I_C = f(V_{CE})$

1 pulse  
 $T_C = 25\text{ °C}$   
 $T_j \leq 150\text{ °C}$

Not recommended for linear duty

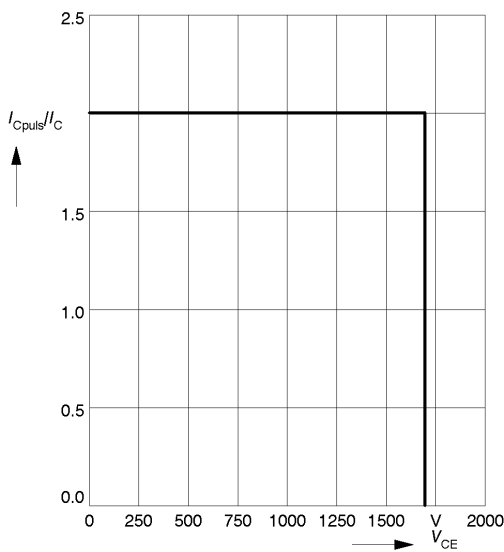


Fig. 5 Turn-off safe operating area (RBSOA)

$T_j \leq 150\text{ °C}$   
 $V_{GE} = \pm 15\text{ V}$   
 $R_{Goff} = 10\text{ }\Omega$   
 $I_C = 75\text{ A}$

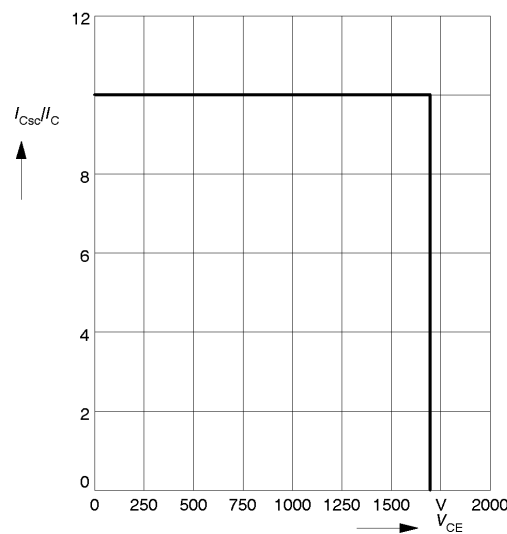


Fig. 6 Safe operating area at short circuit  $I_C = f(V_{CE})$

$T_j \leq 150\text{ °C}$   
 $V_{GE} = \pm 15\text{ V}$   
 $t_{sc} \leq 10\text{ }\mu\text{s}$   
 $L_{ext} < 50\text{ nH}$   
 $I_C = 75\text{ A}$

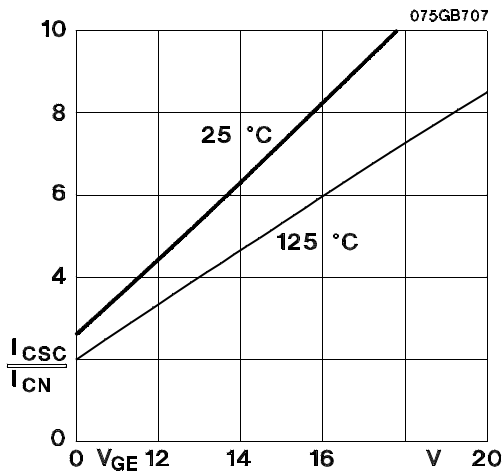


Fig. 7 Short circuit current vs. turn-on gate voltage

$V_C = 1200 \text{ V}$   
 $I_C = I_{CN} = 75 \text{ A}$   
 $t_p = 10 \mu\text{s}$   
 $L_{\text{ext}} \leq 25 \text{ nH}$   
 $R_{\text{Gon}} = 10 \Omega$   
 $R_{\text{Goff}} = 10 \Omega$

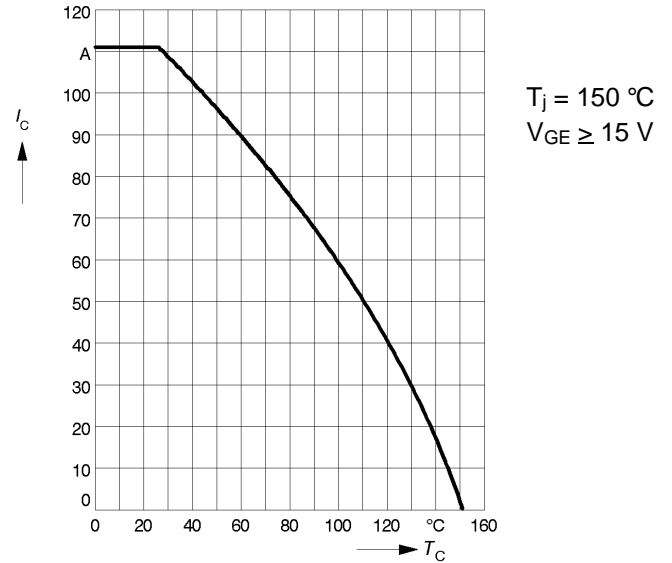


Fig. 8 Rated current vs. temperature  $I_C = f(T_C)$

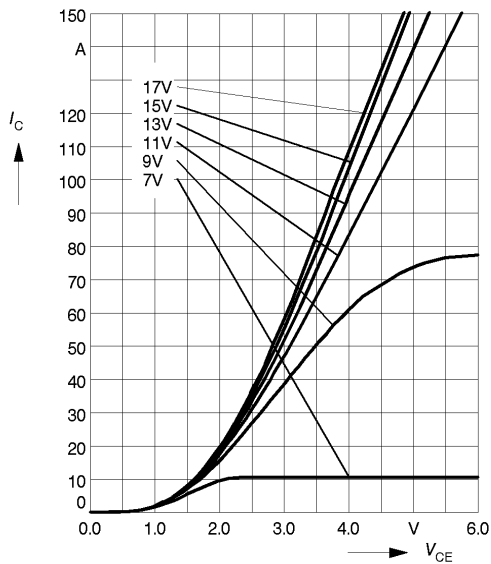


Fig. 9 Typ. output characteristic,  $t_p = 80 \mu\text{s}$ ;  $T_j = 25 \text{ °C}$

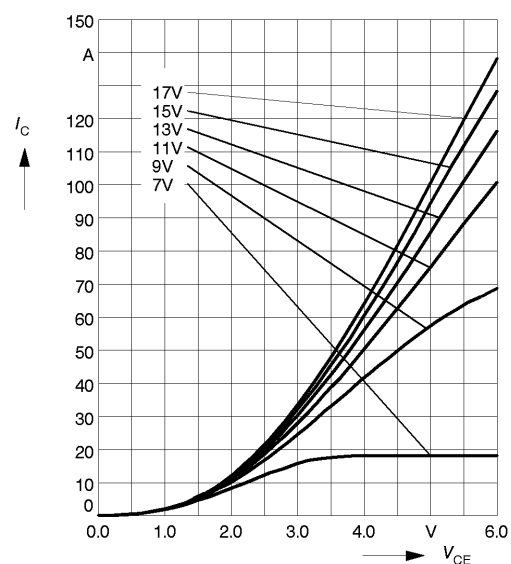


Fig. 10 Typ. output characteristic,  $t_p = 80 \mu\text{s}$ ;  $T_j = 125 \text{ °C}$

$$P_{\text{cond}(t)} = V_{\text{CEsat}(t)} \cdot I_C(t)$$

$$V_{\text{CEsat}(t)} = V_{\text{CE(To)(Tj)}} + r_{\text{CE}(Tj)} \cdot I_C(t)$$

$$V_{\text{CE(To)(Tj)}} \leq 1,9 + 0,003 (T_j - 25) [\text{V}]$$

$$r_{\text{CE}(Tj)} = 0,023 + 0,00007 (T_j - 25) [\Omega]$$

valid for  $V_{\text{GE}} = +15 \frac{+2}{-1} [\text{V}]$ ;  $I_C > 0,3 I_{\text{Cnom}}$

Fig. 11 Typ. saturation characteristic (IGBT)  
Calculation elements and equations

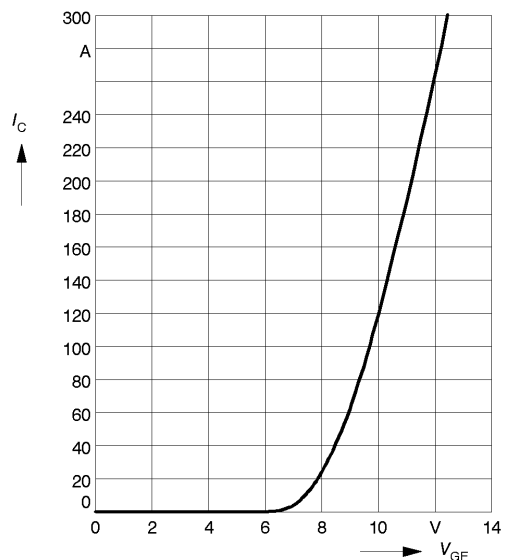


Fig. 12 Typ. transfer characteristic,  $t_p = 80 \mu\text{s}$ ;  $V_{\text{CE}} = 20 \text{ V}$

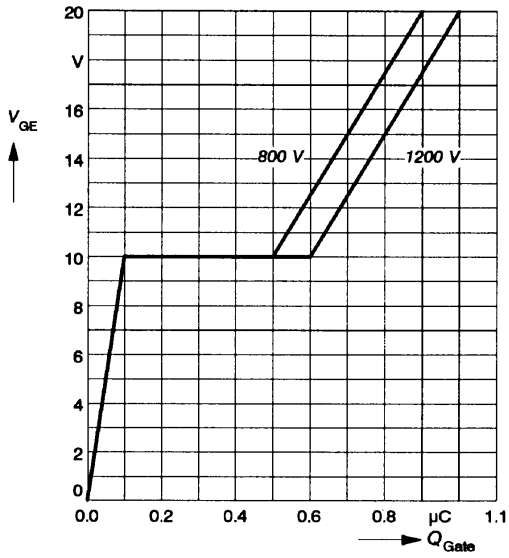


Fig. 13 Typ. gate charge characteristic

$I_{Cpuls} = 75 \text{ A}$

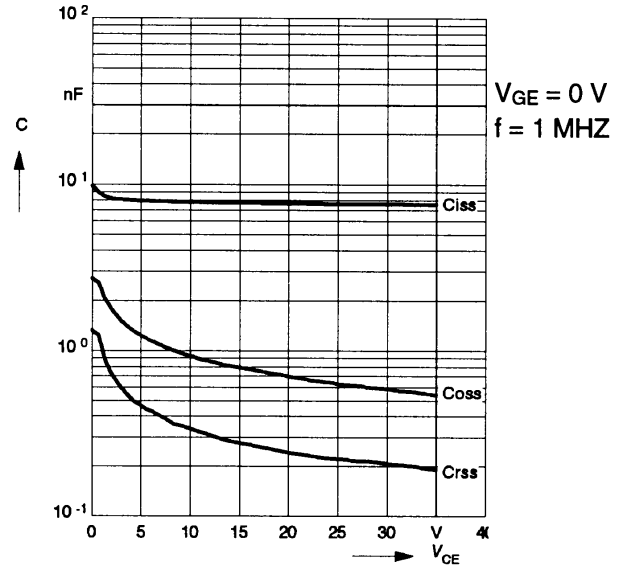


Fig. 14 Typ. capacitances vs.  $V_{CE}$

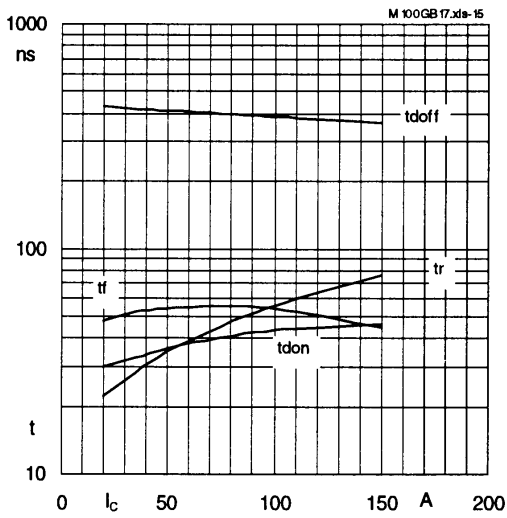


Fig. 15 Typ. switching times vs.  $I_c$

$T_j = 125 \text{ }^\circ\text{C}$   
 $V_{CE} = 1200 \text{ V}$   
 $V_{GE} = \pm 15 \text{ V}$   
 $R_G = 10 \text{ } \Omega$   
 ind. load

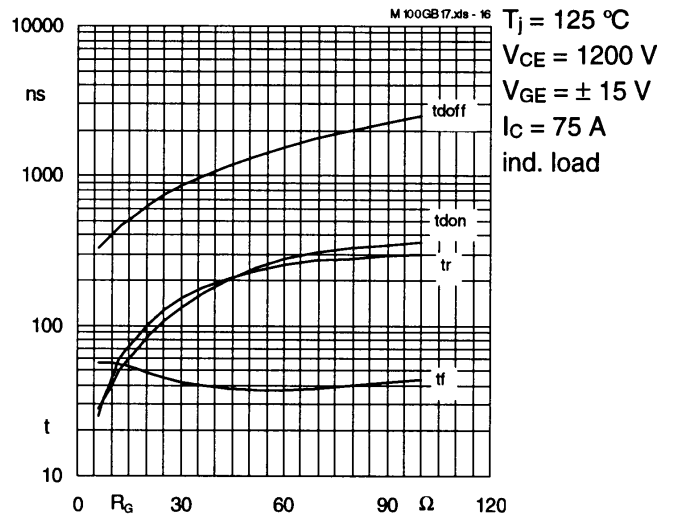


Fig. 16 Typ. switching times vs.  $R_G$

$T_j = 125 \text{ }^\circ\text{C}$   
 $V_{CE} = 1200 \text{ V}$   
 $V_{GE} = \pm 15 \text{ V}$   
 $I_c = 75 \text{ A}$   
 ind. load

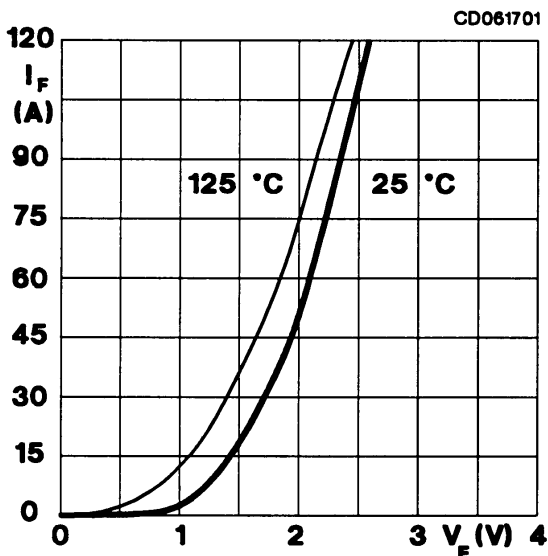


Fig. 17 Typ. CAL diode forward characteristic

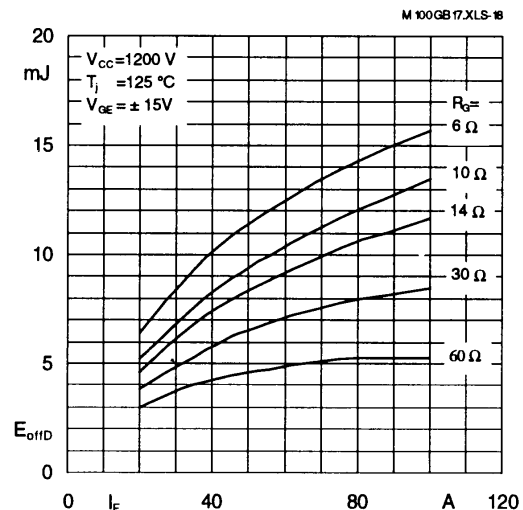


Fig. 18 Typ. Diode turn-off energy dissipation per pulse

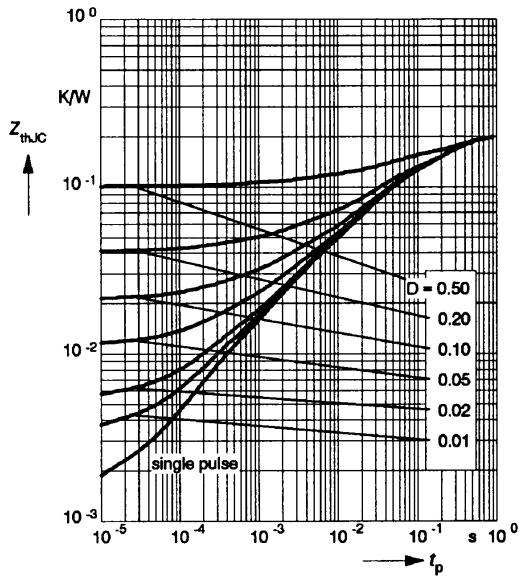


Fig. 19 Transient thermal impedance of IGBT:  $Z_{thjC} = f(t_p)$ ;  $D = t_p / t_c = t_p \cdot f$

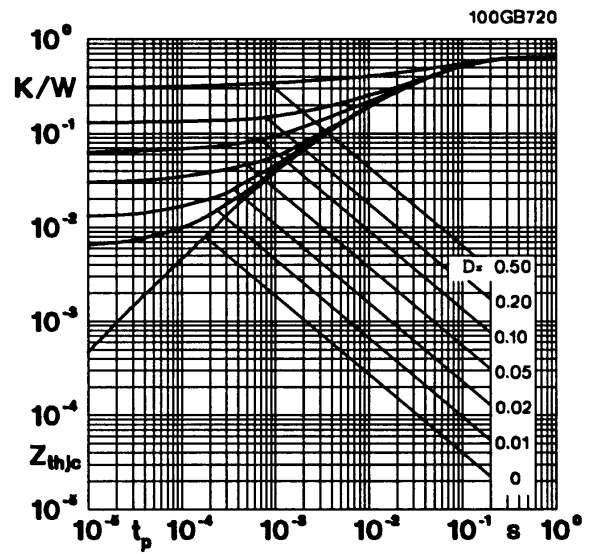


Fig. 20 Transient thermal impedance of inverse diode:  $Z_{thjC} = f(t_p)$

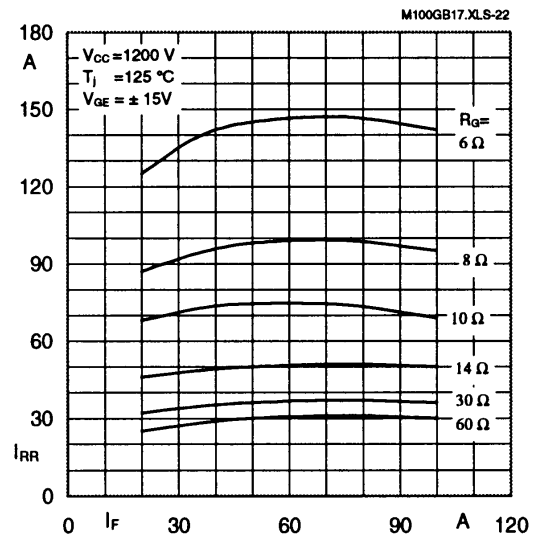


Fig. 22 Typ. CAL diode peak reverse recovery current  $I_{RR} = f(I_F; R_G)$

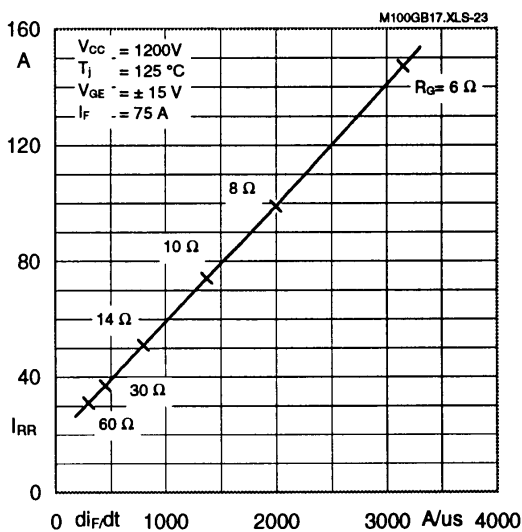


Fig. 23 Typ. CAL diode peak reverse recovery current  $I_{RR} = f(di/dt)$

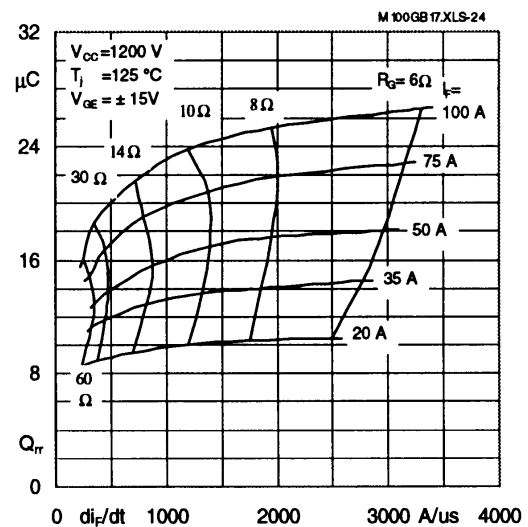
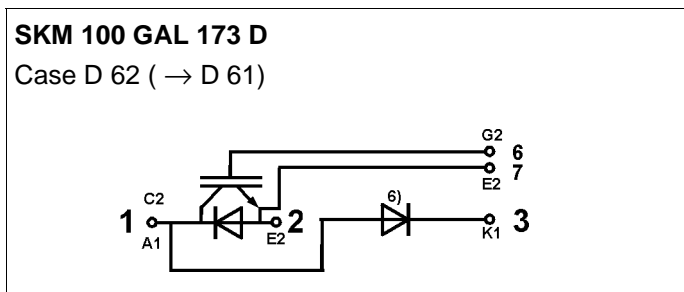
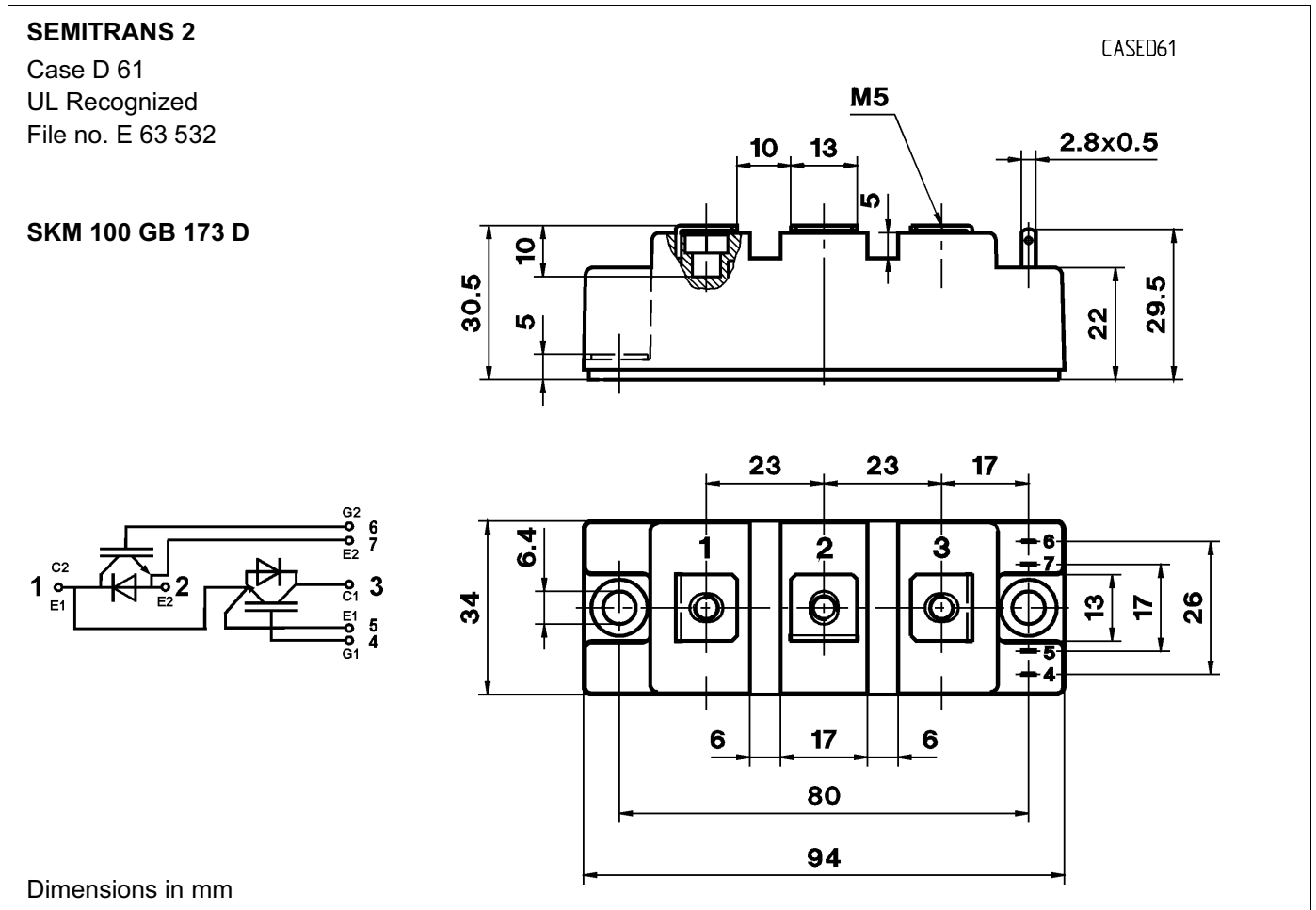


Fig. 24 Typ. CAL diode recovered charge  $Q_{rr}$



Case outline and circuit diagram

| Mechanical Data |  |      | Values    |      |         | Units            |
|-----------------|--|------|-----------|------|---------|------------------|
| Symbol          | Conditions   |      | min.      | typ. | max.    |                  |
| M <sub>1</sub>  | to heatsink, SI Units<br>to heatsink, US Units     | (M6) | 3<br>27   | —    | 5<br>44 | Nm<br>lb.in.     |
| M <sub>2</sub>  | for terminals, SI Units<br>for terminals, US Units | (M5) | 2,5<br>22 | —    | 5<br>44 | Nm<br>lb.in.     |
| a               |  |      | —         | —    | 5x9,81  | m/s <sup>2</sup> |
| w               |  |      | —         | —    | 160     | g                |

This is an electrostatic discharge sensitive device (ESDS). Please observe the international standard IEC 747-1, Chapter IX.

Eight devices are supplied in one SEMIBOX A without mounting hardware, which can be ordered separately under Ident No. 33321100 (for 10 SEMITRANS 2)

Larger packing units of 20 or 42 pieces are used if suitable

<sup>6)</sup> Freewheeling diode → page B 6 – 47, remark 6.

This technical information specifies semiconductor devices but promises no characteristics. No warranty or guarantee expressed or implied is made regarding delivery, performance or suitability.